

PS9552, PS9552L1, PS9552L2, PS9552L3

2.5 A OUTPUT CURRENT, HIGH CMR IGBT GATE DRIVE PHOTOCOUPLER 8-PIN DIP PHOTOCOUPLER

—NEPOC Series—

DESCRIPTION

The PS9552, PS9552L1, PS9552L2 and PS9552L3 are optically coupled isolators containing a GaAlAs LED on the input side and a photo diode, a signal processing circuit and a power output transistor on the output side on one chip.

The PS9552 Series is designed specifically for high common mode transient immunity (CMR), high output current and high switching speed.

The PS9552 Series is suitable for driving IGBTs and MOS FETs.

The PS9552 Series is in a plastic DIP (Dual In-line Package).

The PS9552L1 is lead bending type for long creepage distance.

The PS9552L2 is lead bending type for long creepage distance (Gull-wing) for surface mount.

The PS9552L3 is lead bending type (Gull-wing) for surface mounting.

FEATURES

- Long creepage distance (8 mm MIN.: PS9552L1, PS9552L2)
- Large peak output current (2.5 A MAX., 2.0 A MIN.)
- High speed switching (t_{PLH} , t_{PHL} = 0.5 μ s MAX.)
- UVLO (Under Voltage Lock Out) protection with hysteresis
- High common mode transient immunity (CM_H , CM_L = ± 25 kV/ μ s MIN.)
- Ordering number of tape product: PS9552L2-E3: 1 000 pcs/reel
: PS9552L3-E3: 1 000 pcs/reel

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- Pb-Free product
- Safety standards

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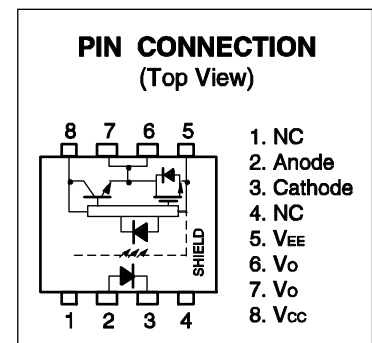
- CSA approved: No. CA 101391 (CA5A, CAN/CSA-C22.2 60065, 60950)
- BSI approved: No. 8937, 8938
- SEMKO approved: No. 615433
- NEMKO approved: No. P06207243
- DEMKO approved: No. 314091
- FIMKO approved: No. FI 22827

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- DIN EN60747-5-2 (VDE0884 Part2) approved: No. 40019182 (Option)

APPLICATIONS

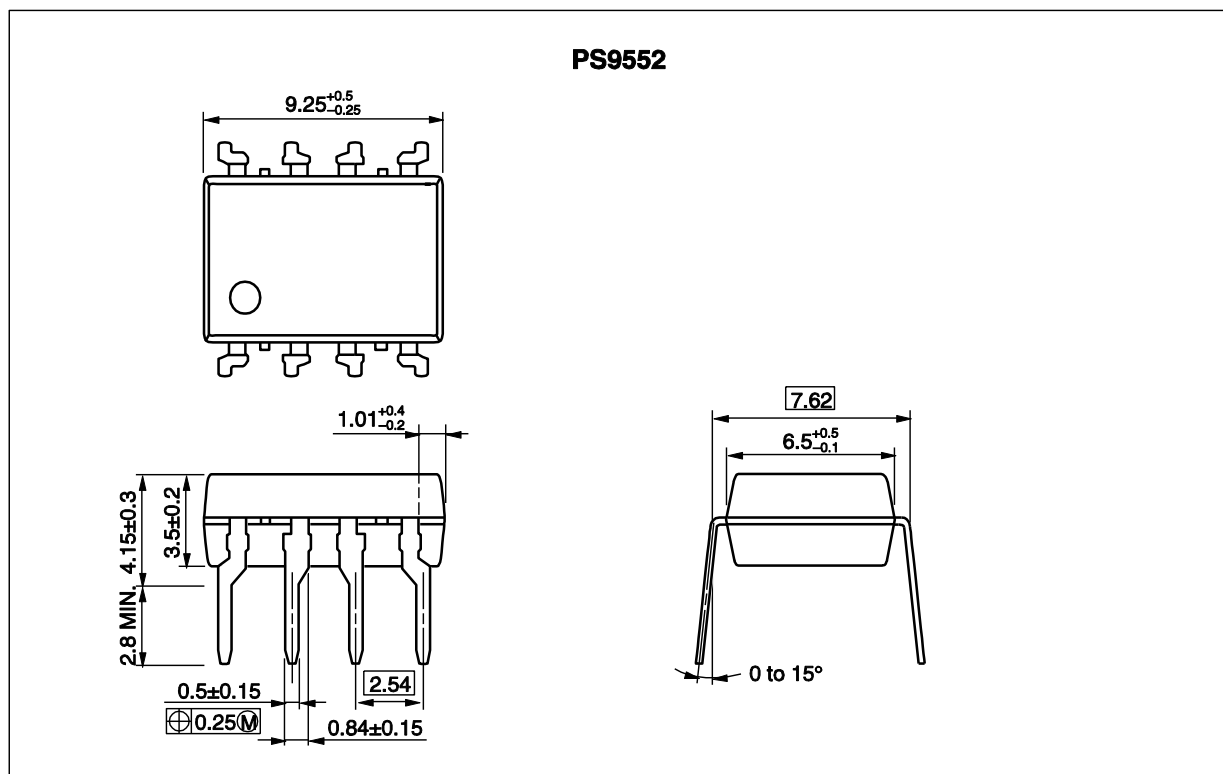
- IGBT, Power MOS FET Gate Driver
- Industrial inverter
- IH (Induction Heating)



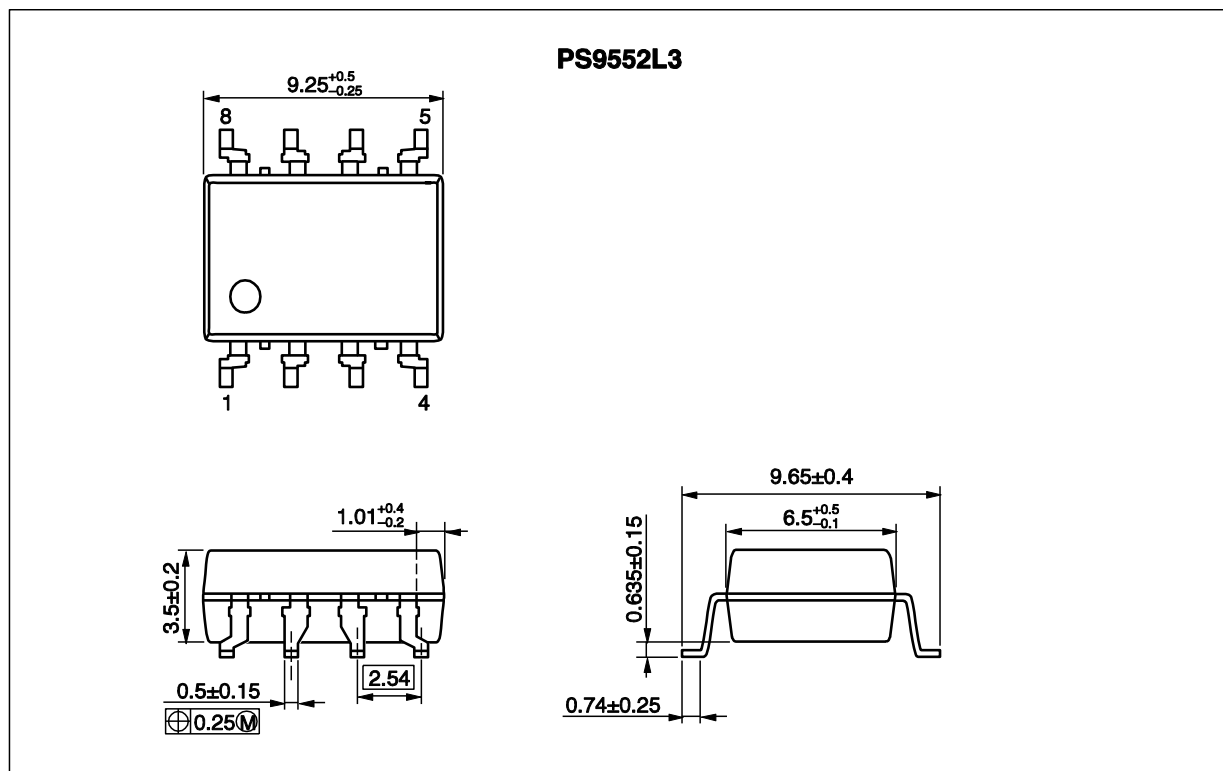
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<R> **PACKAGE DIMENSIONS (UNIT: mm)**

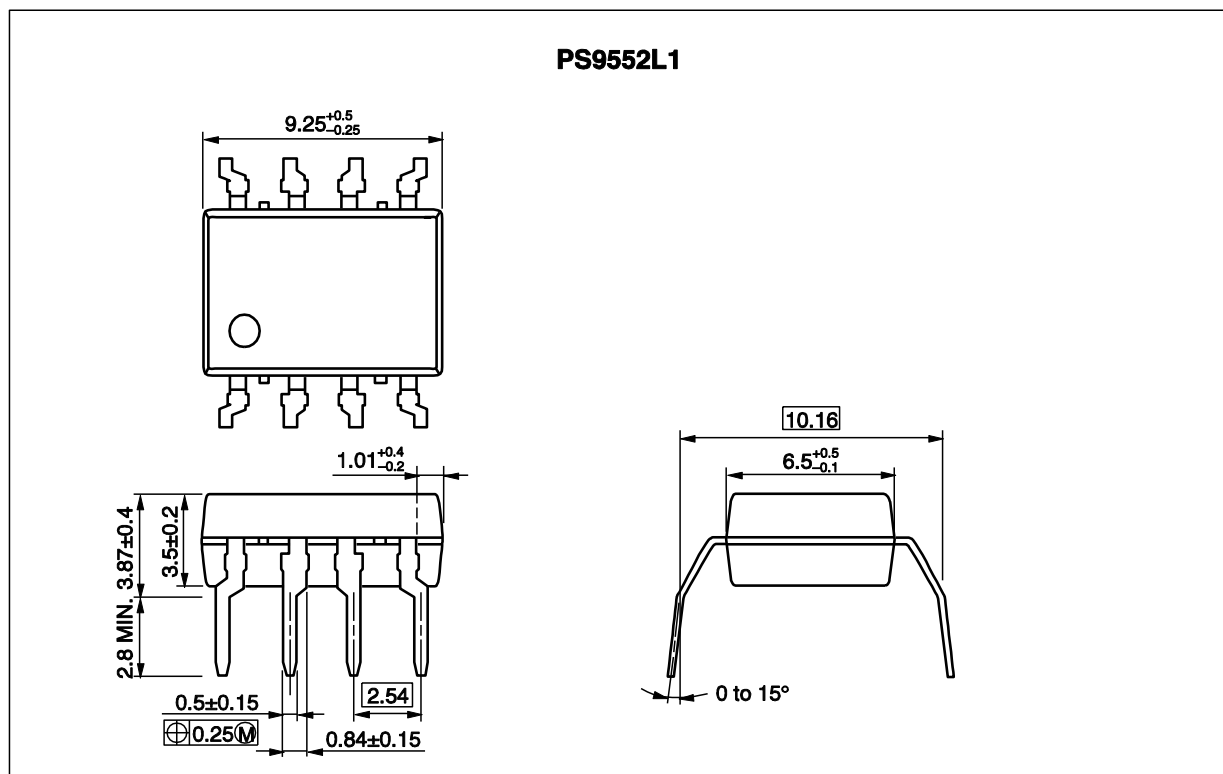
DIP Type



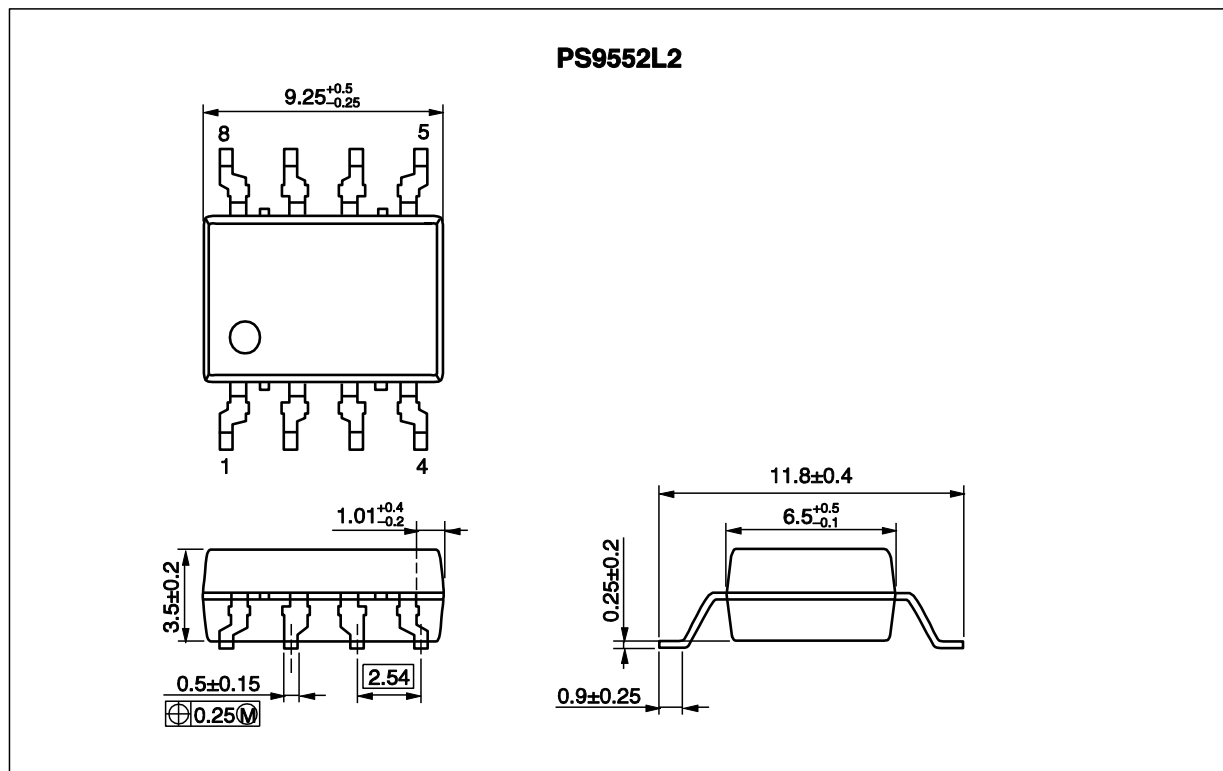
Lead Bending Type (Gull-wing) For Surface Mount



Lead Bending Type For Long Creepage Distance

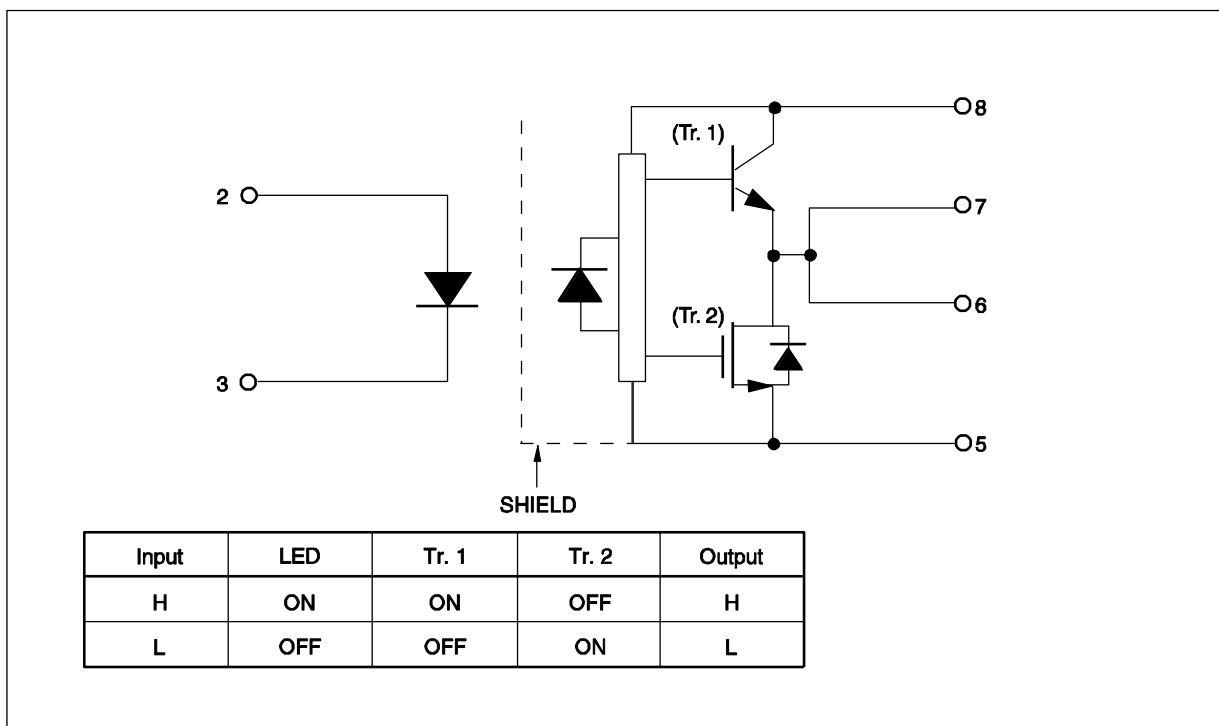
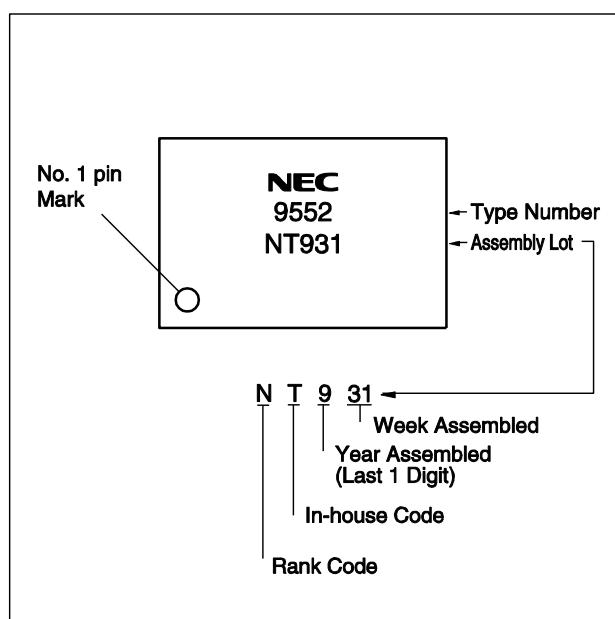


Lead Bending Type (Gull-wing) For Long Creepage Distance (Surface Mount)



PHOTOCOUPLER CONSTRUCTION

Parameter	PS9552, PS9552L3	PS9552L1, PS9552L2
Air Distance (MIN.)	7 mm	8 mm
Outer Creepage Distance (MIN.)	7 mm	8 mm
Isolation Distance (MIN.)	0.4 mm	0.4 mm

FUNCTIONAL DIAGRAM

<R> MARKING EXAMPLE


ORDERING INFORMATION

Part Number	Order Number	Solder Plating Specification	Packing Style	Safety Standard Approval	Application Part Number* ¹
PS9552	PS9552-AX	(Pb-Free (Ni/Pd/Au)	Magazine case 50 pcs	Standard products (UL, CSA, BSI, SEMKO, NEMKO, DEMKO, FIMKO approved)	PS9552
PS9552L1	PS9552L1-AX				PS9552L1
PS9552L2	PS9552L2-AX				PS9552L2
PS9552L3	PS9552L3-AX				PS9552L3
PS9552L2-E3	PS9552L2-E3-AX				PS9552L2
PS9552L3-E3	PS9552L3-E3-AX				PS9552L3
PS9552-V	PS9552-V-AX		Magazine case 50 pcs	DIN EN60747-5-2 (VDE0884 Part2) Approved (Option)	PS9552
PS9552L1-V	PS9552L1-V-AX				PS9552L1
PS9552L2-V	PS9552L2-V-AX				PS9552L2
PS9552L3-V	PS9552L3-V-AX				PS9552L3
PS9552L2-V-E3	PS9552L2-V-E3-AX				PS9552L2
PS9552L3-V-E3	PS9552L3-V-E3-AX				PS9552L3

*1 For the application of the Safety Standard, following part number should be used.

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$, unless otherwise specified)

Parameter		Symbol	Ratings	Unit
Diode	Forward Current	I_F	25	mA
	Peak Transient Forward Current (Pulse Width $< 1 \mu\text{s}$)	$I_{F(\text{TRAN})}$	1.0	A
	Reverse Voltage	V_R	5	V
Detector	High Level Peak Output Current ^{*1}	$I_{OH(\text{PEAK})}$	2.5	A
	Low Level Peak Output Current ^{*1}	$I_{OL(\text{PEAK})}$	2.5	A
	Supply Voltage	$(V_{CC} - V_{EE})$	0 to 35	V
	Output Voltage	V_O	0 to V_{CC}	V
	Power Dissipation ^{*2}	P_C	250	mW
Isolation Voltage ^{*3}		BV	5 000	Vr.m.s.
Total Power Dissipation ^{*4}		P_T	300	mW
Operating Frequency ^{*5}		f	50	kHz
Operating Ambient Temperature		T_A	-40 to +100	$^\circ\text{C}$
Storage Temperature		T_{stg}	-55 to +125	$^\circ\text{C}$

^{*1} Maximum pulse width = 10 μs , Maximum duty cycle = 0.2%

^{*2} Reduced to 4.8 mW/ $^\circ\text{C}$ at $T_A = 70^\circ\text{C}$ or more.

^{*3} AC voltage for 1 minute at $T_A = 25^\circ\text{C}$, RH = 60% between input and output.

Pins 1-4 shorted together, 5-8 shorted together.

^{*4} Reduced to 5.4 mW/ $^\circ\text{C}$ at $T_A = 70^\circ\text{C}$ or more.

^{*5} $I_{OH(\text{PEAK})} \leq 2.0 \text{ A}$ ($\leq 0.3 \mu\text{s}$), $I_{OL(\text{PEAK})} \leq 2.0 \text{ A}$ ($\leq 0.3 \mu\text{s}$)

RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	MIN.	TYP.	MAX.	Unit
Supply Voltage	$(V_{CC} - V_{EE})$	15		30	V
Forward Current (ON)	$I_{F(\text{ON})}$	7	10	16	mA
Forward Voltage (OFF)	$V_{F(\text{OFF})}$	-2		0.8	V
Operating Ambient Temperature	T_A	-40		100	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS ($T_A = -40$ to $+100^\circ\text{C}$, $V_{CC} = 15$ to 30 V , $I_F(\text{ON}) = 7$ to 16 mA , $V_F(\text{OFF}) = -2$ to 0.8 V , $V_{EE} = \text{GND}$, unless otherwise specified)

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Parameter		Symbol	Conditions	MIN.	TYP. ^{*1}	MAX.	Unit
Diode	Forward Voltage	V_F	$I_F = 10\text{ mA}$, $T_A = 25^\circ\text{C}$	1.3	1.65	2.1	V
	Input Capacitance	C_{IN}	$f = 1\text{ MHz}$, $V_F = 0\text{ V}$, $T_A = 25^\circ\text{C}$		30		pF
Detector	High Level Output Current	I_{OH}	$V_O = (V_{CC} - 4\text{ V})^{*2}$	0.5	2.0		A
			$V_O = (V_{CC} - 15\text{ V})^{*3}$	2.0			
	Low Level Output Current	I_{OL}	$V_O = (V_{EE} + 2.5\text{ V})^{*2}$	0.5	2.0		A
			$V_O = (V_{EE} + 15\text{ V})^{*3}$	2.0			
	High Level Output Voltage	V_{OH}	$I_O = -100\text{ mA}^{*4}$	$V_{CC} - 3.5$	$V_{CC} - 2.5$	$V_{CC} - 1.5$	V
	Low Level Output Voltage	V_{OL}	$I_O = 100\text{ mA}$		0.1	0.5	V
	High Level Supply Current	I_{CCH}	$V_O = \text{open}$, $I_F = 7$ to 16 mA		2.0	5.0	mA
	Low Level Supply Current	I_{CCL}	$V_O = \text{open}$, $V_F = -2$ to $+0.8\text{ V}$		2.0	5.0	mA
	UVLO Threshold	V_{UVLO+}	$V_O > 5\text{ V}$, $I_F = 10\text{ mA}$	11.0	12.3	13.5	V
		V_{UVLO-}		9.5	10.7	12.0	
	UVLO Hysteresis	$UVLO_{HYS}$	$V_O > 5\text{ V}$, $I_F = 10\text{ mA}$		1.6		V
Coupled	Threshold Input Current (L $\rightarrow$ H)	I_{FLH}	$I_O = 0\text{ mA}$, $V_O > 5\text{ V}$		2.0	5.0	mA
	Threshold Input Voltage (H $\rightarrow$ L)	V_{FHL}	$I_O = 0\text{ mA}$, $V_O < 5\text{ V}$	0.8			V

*1 Typical values at $T_A = 25^\circ\text{C}$.

*2 Maximum pulse width = $50\text{ }\mu\text{s}$, Maximum duty cycle = 0.5%.

*3 Maximum pulse width = $10\text{ }\mu\text{s}$, Maximum duty cycle = 0.2%

*4 V_{OH} is measured with the DC load current in this testing (Maximum pulse width = 2 ms , Maximum duty cycle = 20%).

SWITCHING CHARACTERISTICS ($T_A = -40$ to $+100^\circ\text{C}$, $V_{CC} = 15$ to 30 V , $I_F(\text{ON}) = 7$ to 16 mA ,
 $V_F(\text{OFF}) = -2$ to 0.8 V , $V_{EE} = \text{GND}$, unless otherwise specified)

Parameter	Symbol	Conditions	MIN.	TYP. ^{*1}	MAX.	Unit
Propagation Delay Time (L → H)	t_{PLH}	$R_g = 10\ \Omega$, $C_g = 10\text{ nF}$, $f = 10\text{ kHz}$, Duty Cycle = 50% ^{*2} , $I_F = 7$ to 16 mA	0.1	0.3	0.5	μs
Propagation Delay Time (H → L)	t_{PHL}		0.1	0.3	0.5	μs
Pulse Width Distortion (PWD)	$ t_{PHL} - t_{PLH} $				0.3	μs
Propagation Delay Time (Difference Between Any Two Products)	$t_{PHL} - t_{PLH}$		-0.35		0.35	μs
Rise Time	t_r			0.1		μs
Fall Time	t_f			0.1		μs
UVLO (Turn On Delay)	$t_{UVLO\text{ ON}}$	$V_O > 5\text{ V}$, $I_F = 10\text{ mA}$		0.8		μs
UVLO (Turn Off Delay)	$t_{UVLO\text{ OFF}}$	$V_O < 5\text{ V}$, $I_F = 10\text{ mA}$		0.6		μs
Common Mode Transient Immunity at High Level Output ^{*3}	$ CM_H $	$T_A = 25^\circ\text{C}$, $I_F = 10$ to 16 mA , $V_{CC} = 30\text{ V}$, $V_{O(\text{MIN})} = 26\text{ V}$, $V_{CM} = 1.5\text{ kV}$	25			$\text{kV}/\mu\text{s}$
Common Mode Transient Immunity at Low Level Output ^{*3}	$ CM_L $	$T_A = 25^\circ\text{C}$, $I_F = 0\text{ mA}$, $V_{CC} = 30\text{ V}$, $V_{O(\text{MAX})} = 1\text{ V}$, $V_{CM} = 1.5\text{ kV}$	25			$\text{kV}/\mu\text{s}$

***1** Typical values at $T_A = 25^\circ\text{C}$.

***2** This load condition is equivalent to the IGBT load at 1 200 V/75 A.

***3** Connect pin 1 and pin 4 to the LED common.

TEST CIRCUIT

Fig. 1 I_{OH} Test Circuit

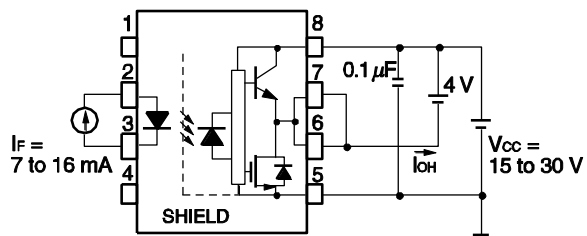


Fig. 2 I_{OL} Test Circuit

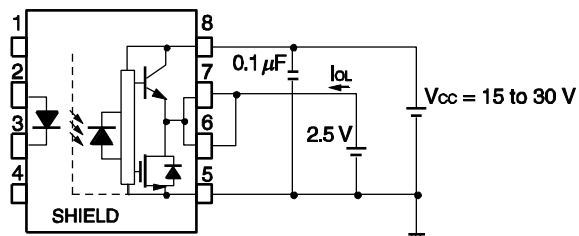


Fig. 3 V_{OH} Test Circuit

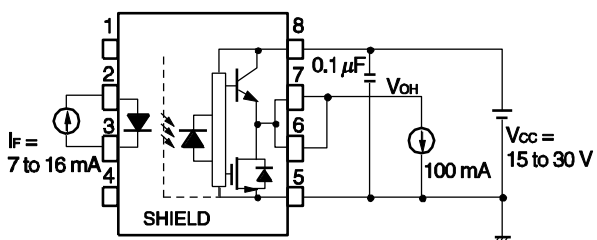


Fig. 4 V_{OL} Test Circuit

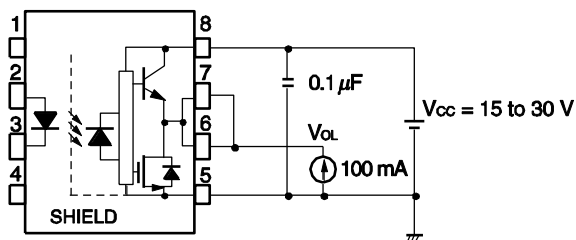


Fig. 5 I_{FLH} Test Circuit

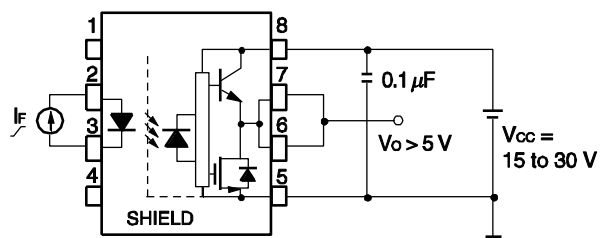


Fig. 6 UVLO Test Circuit

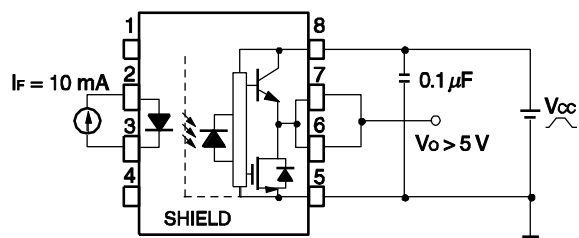


Fig. 7 t_{PLH} , t_{PHL} , t_r , t_f Test Circuit and Wave Forms

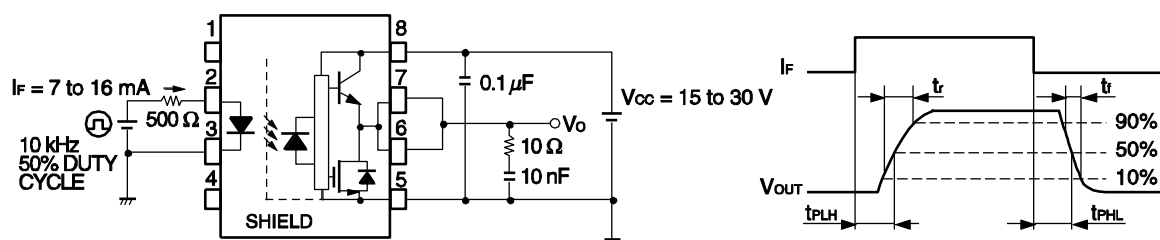
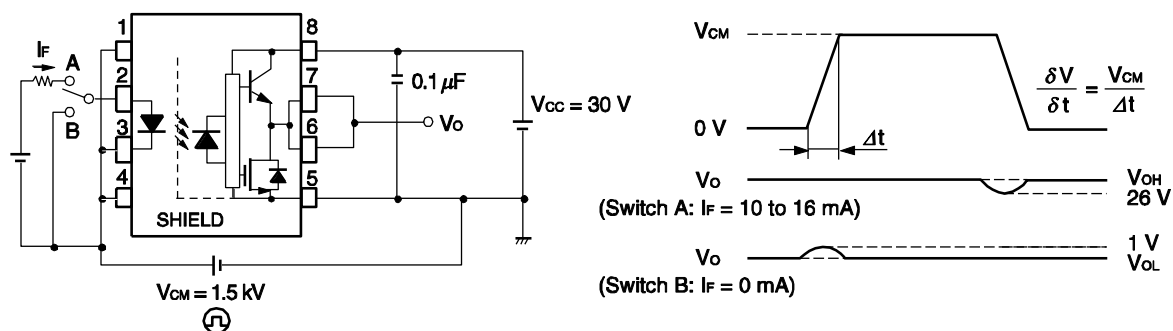


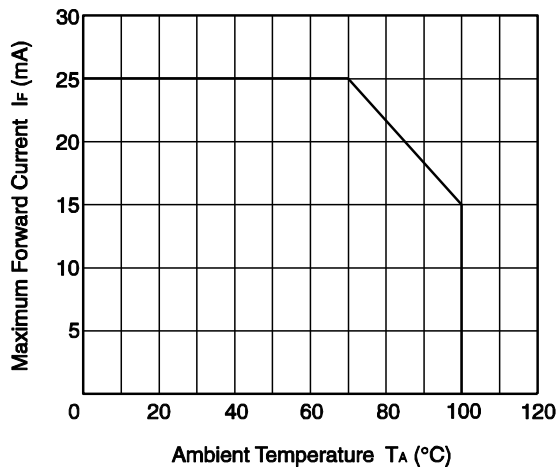
Fig. 8 CMR Test Circuit and Wave Forms



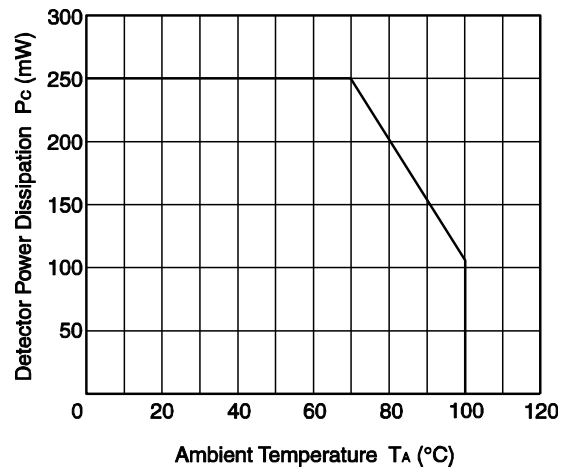
Remark CMR Test : Connect pin 1 and pin 4 to the LED common.

TYPICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$, unless otherwise specified)

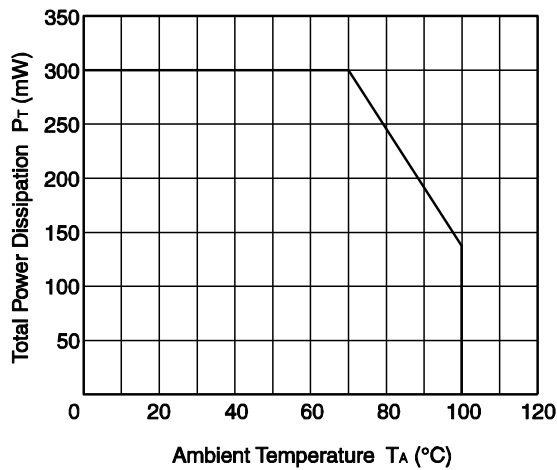
MAXIMUM FORWARD CURRENT
vs. AMBIENT TEMPERATURE



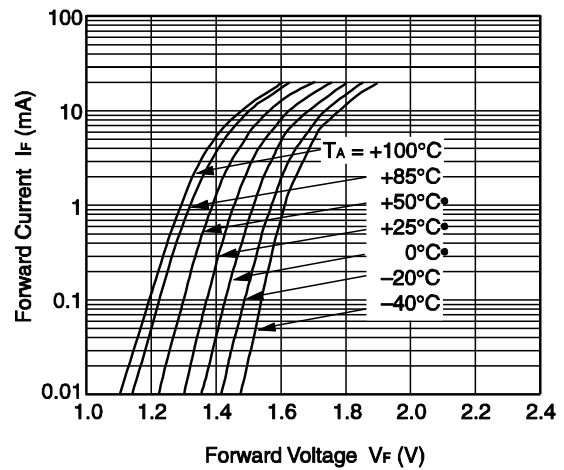
DETECTOR POWER DISSIPATION
vs. AMBIENT TEMPERATURE



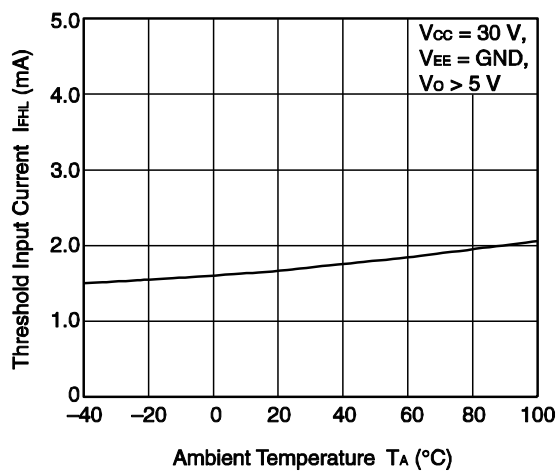
TOTAL POWER DISSIPATION
vs. AMBIENT TEMPERATURE



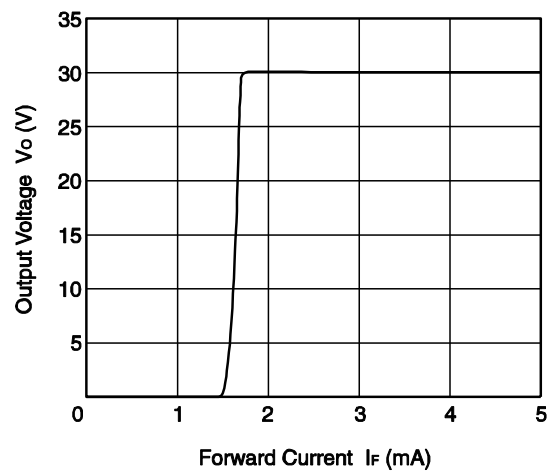
FORWARD CURRENT vs.
FORWARD VOLTAGE



THRESHOLD INPUT CURRENT vs.
AMBIENT TEMPERATURE



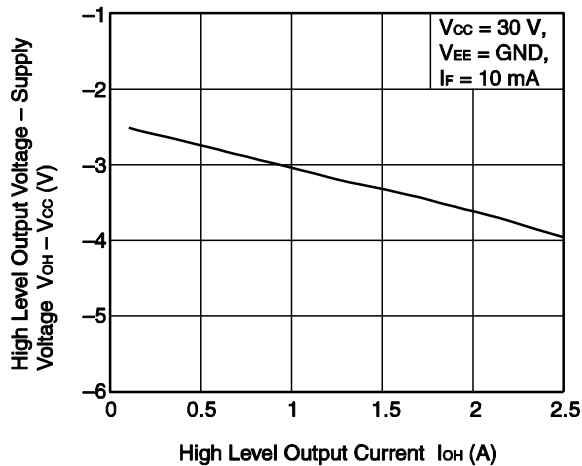
OUTPUT VOLTAGE vs.
FORWARD CURRENT



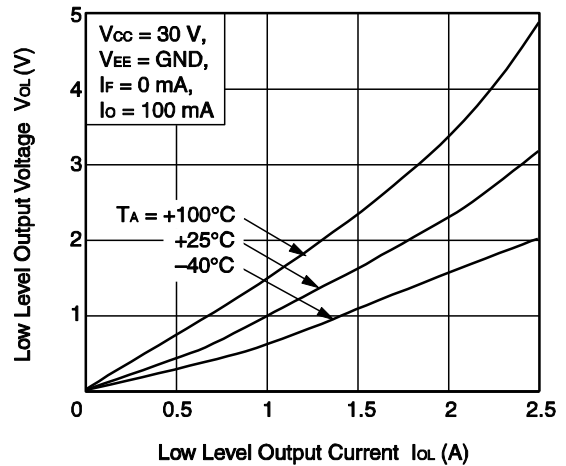
Remark The graphs indicate nominal characteristics.

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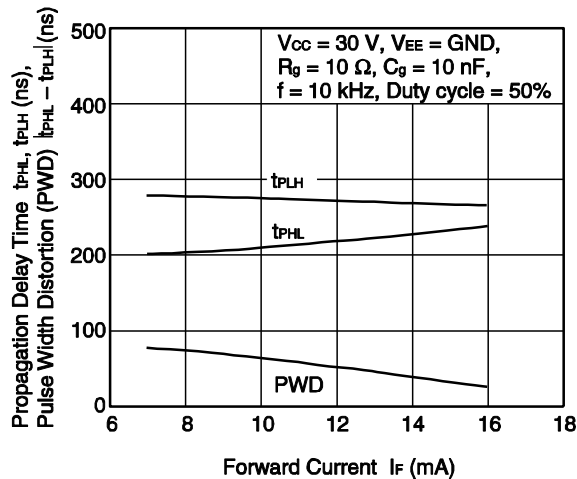
HIGH LEVEL OUTPUT VOLTAGE – SUPPLY VOLTAGE vs. HIGH LEVEL OUTPUT CURRENT



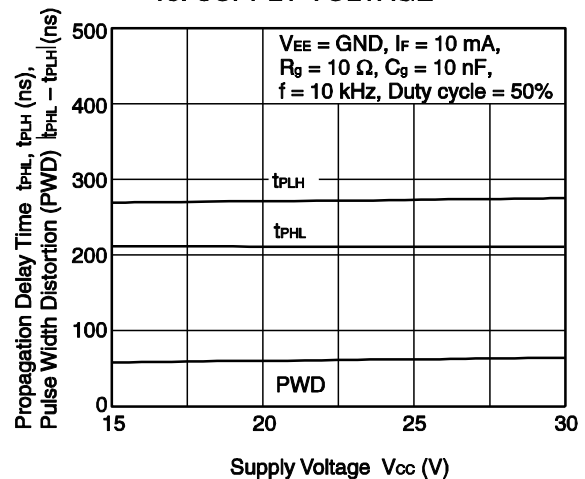
LOW LEVEL OUTPUT VOLTAGE vs. LOW LEVEL OUTPUT CURRENT



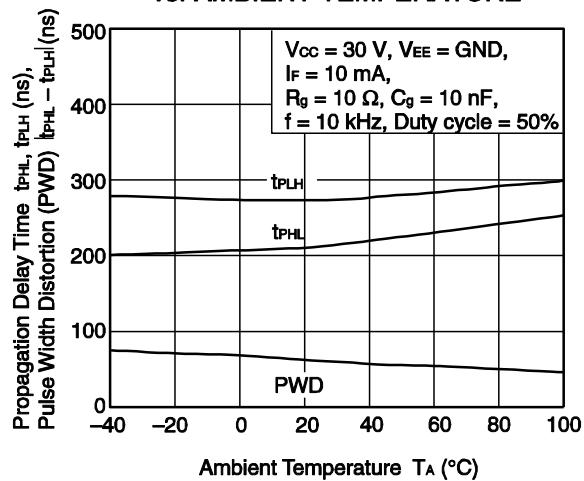
PROPAGATION DELAY TIME, PULSE WIDTH DISTORTION vs. FORWARD CURRENT



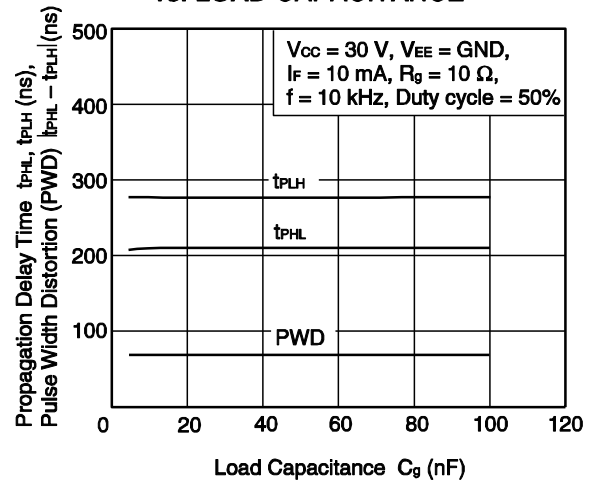
PROPAGATION DELAY TIME, PULSE WIDTH DISTORTION vs. SUPPLY VOLTAGE



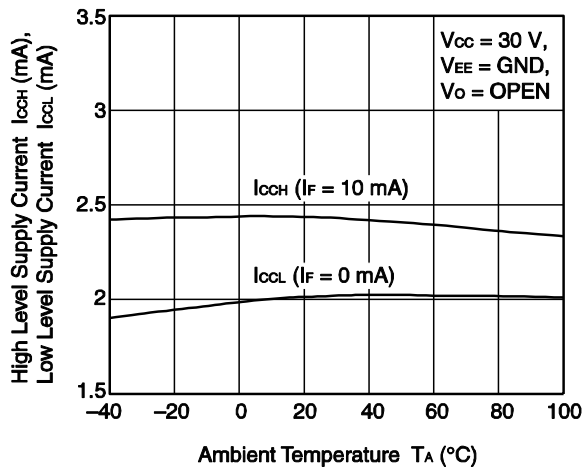
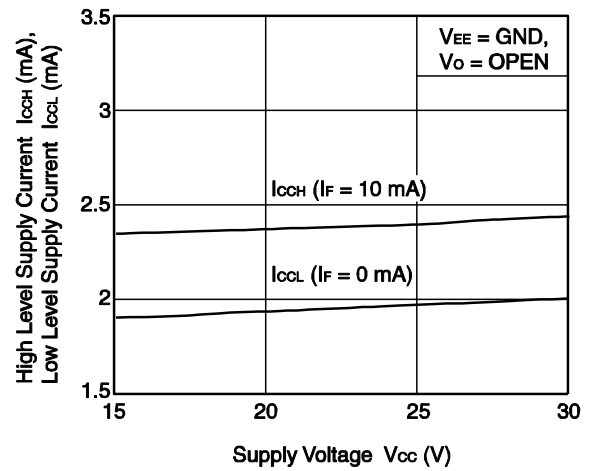
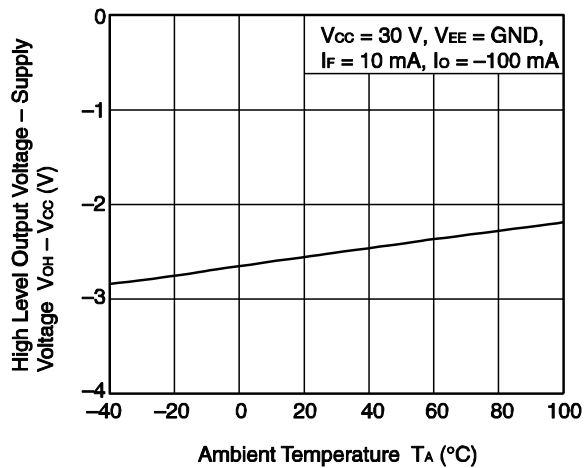
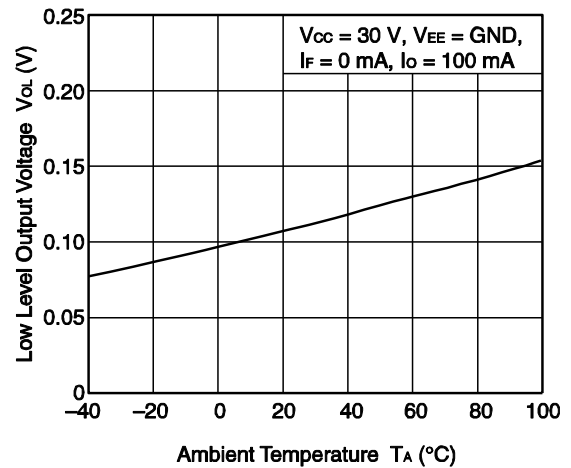
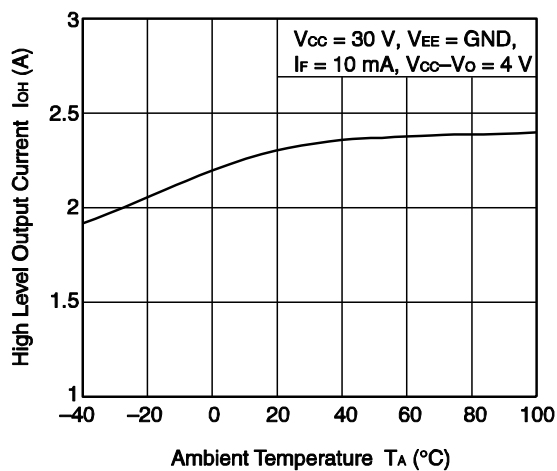
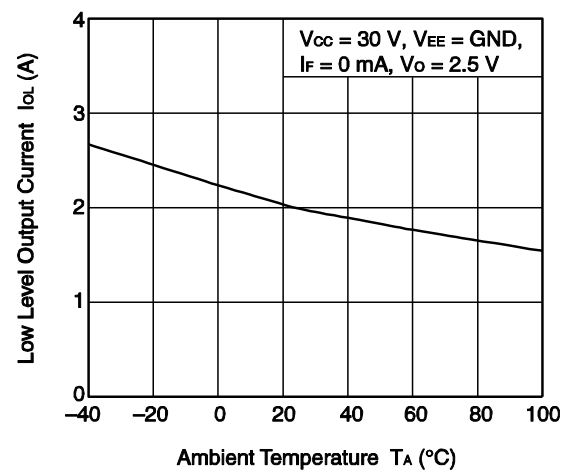
PROPAGATION DELAY TIME, PULSE WIDTH DISTORTION vs. AMBIENT TEMPERATURE



PROPAGATION DELAY TIME, PULSE WIDTH DISTORTION vs. LOAD CAPACITANCE

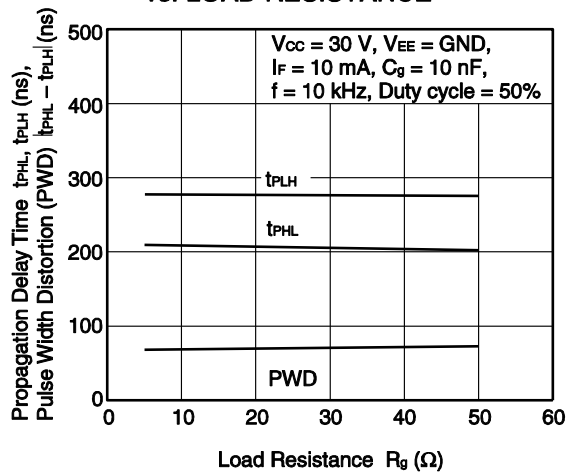


Remark The graphs indicate nominal characteristics.

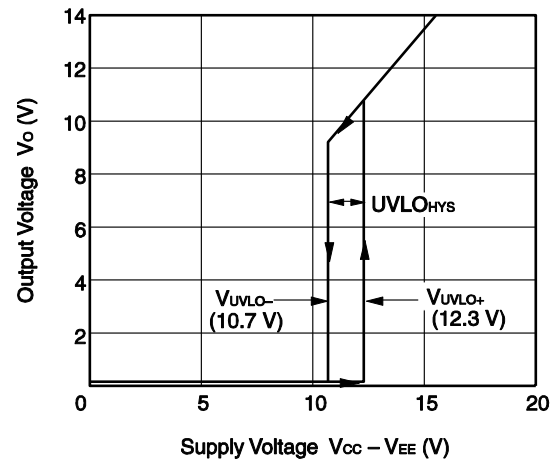
SUPPLY CURRENT vs.
AMBIENT TEMPERATURESUPPLY CURRENT vs.
AMBIENT TEMPERATUREHIGH LEVEL OUTPUT VOLTAGE – SUPPLY
VOLTAGE vs. AMBIENT TEMPERATURELOW LEVEL OUTPUT VOLTAGE vs.
AMBIENT TEMPERATUREHIGH LEVEL OUTPUT CURRENT vs.
AMBIENT TEMPERATURELOW LEVEL OUTPUT CURRENT vs.
AMBIENT TEMPERATURE

Remark The graphs indicate nominal characteristics.

**PROPAGATION DELAY TIME,
PULSE WIDTH DISTORTION
vs. LOAD RESISTANCE**



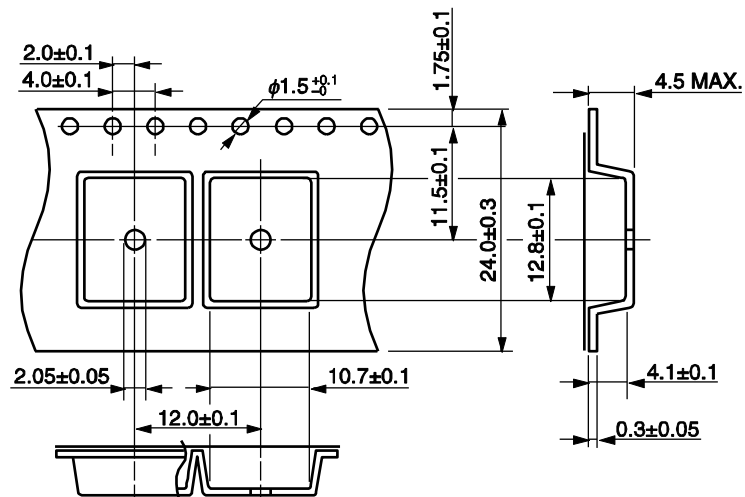
OUTPUT VOLTAGE vs. SUPPLY VOLTAGE



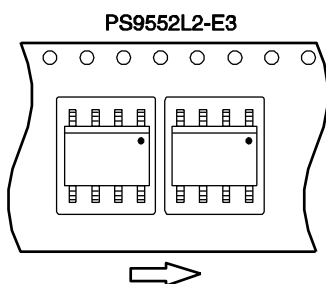
Remark The graphs indicate nominal characteristics.

TAPING SPECIFICATIONS (UNIT: mm)

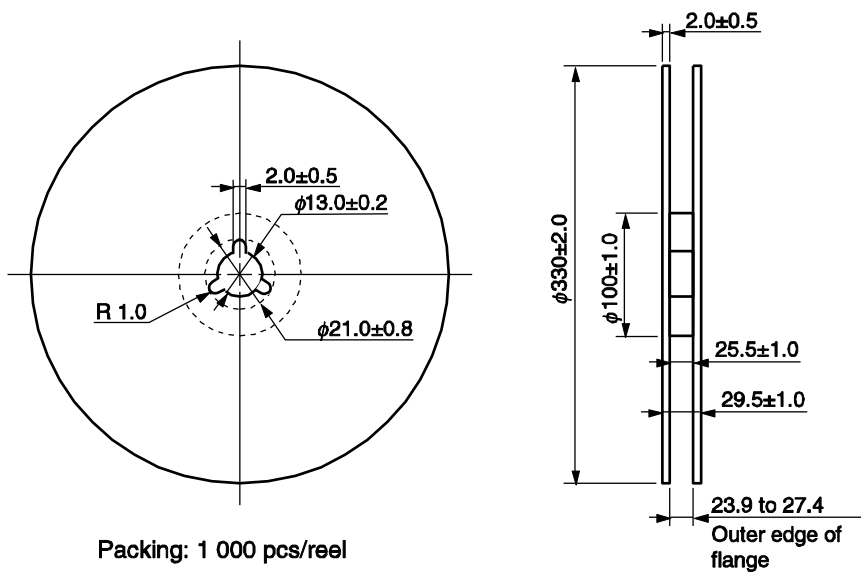
Outline and Dimensions (Tape)



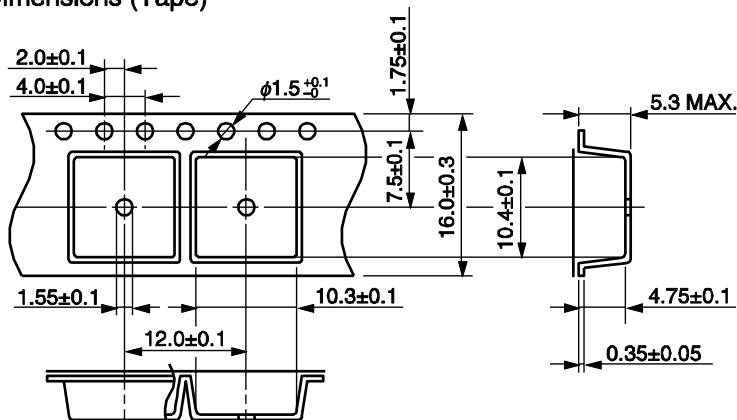
Tape Direction



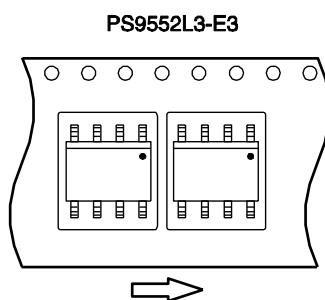
Outline and Dimensions (Reel)



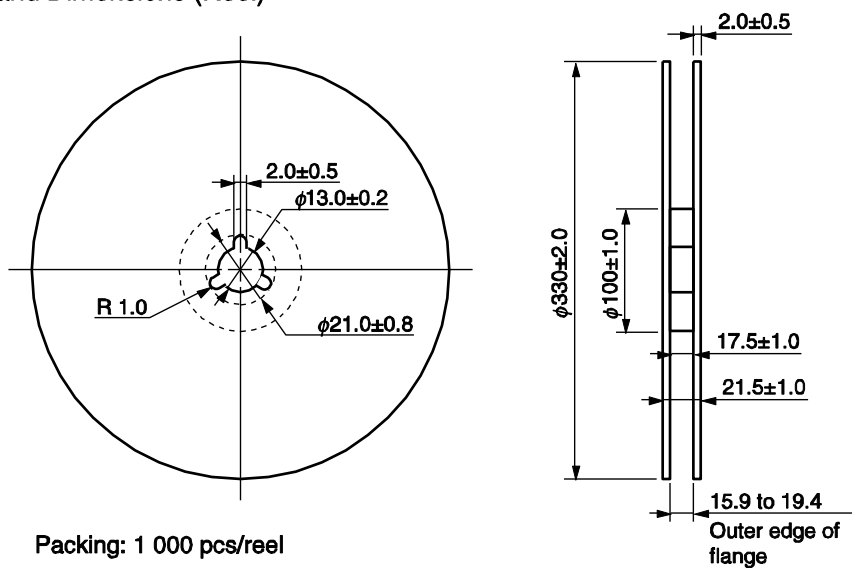
Outline and Dimensions (Tape)



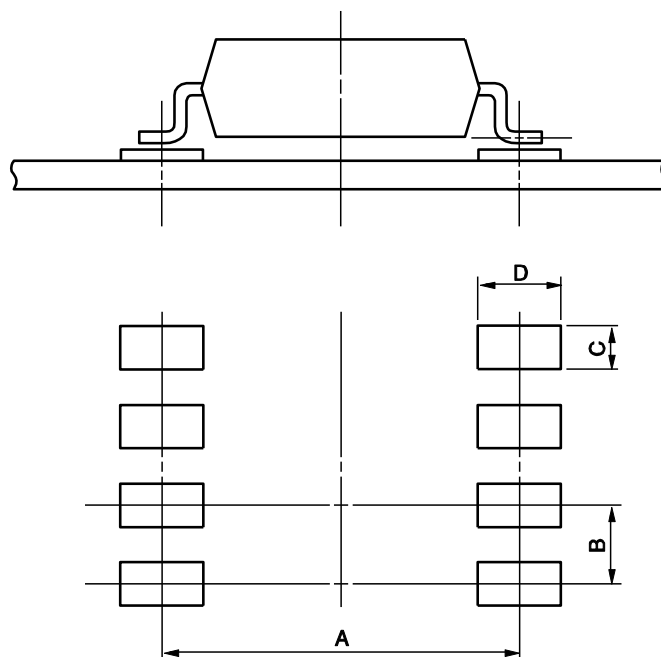
Tape Direction



Outline and Dimensions (Reel)



RECOMMENDED MOUNT PAD DIMENSIONS (UNIT: mm)



Part Number	Lead Bending	A	B	C	D
PS9552L2	lead bending type (Gull-wing) for long creepage distance (surface mount)	10.2	2.54	1.7	2.2
PS9552L3	lead bending type (Gull-wing) for surface mount	8.2	2.54	1.7	2.2

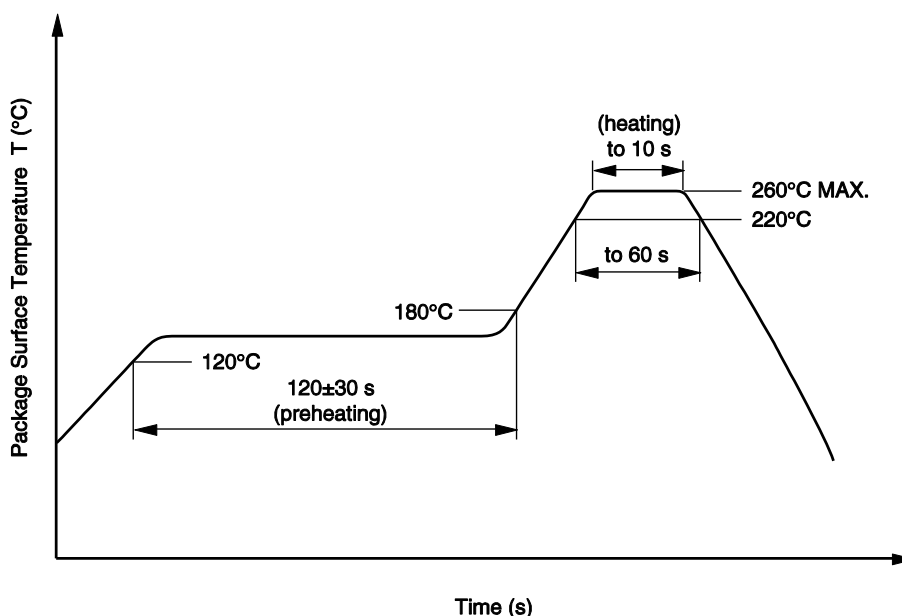
NOTES ON HANDLING

1. Recommended soldering conditions

(1) Infrared reflow soldering

- Peak reflow temperature 260°C or below (package surface temperature)
- Time of peak reflow temperature 10 seconds or less
- Time of temperature higher than 220°C 60 seconds or less
- Time to preheat temperature from 120 to 180°C 120±30 s
- Number of reflows Three
- Flux Rosin flux containing small amount of chlorine (The flux with a maximum chlorine content of 0.2 Wt% is recommended.)

Recommended Temperature Profile of Infrared Reflow



(2) Wave soldering

- Temperature 260°C or below (molten solder temperature)
- Time 10 seconds or less
- Preheating conditions 120°C or below (package surface temperature)
- Number of times One (Allowed to be dipped in solder including plastic mold portion.)
- Flux Rosin flux containing small amount of chlorine (The flux with a maximum chlorine content of 0.2 Wt% is recommended.)

(3) Soldering by Soldering Iron

- Peak Temperature (lead part temperature) 350°C or below
- Time (each pins) 3 seconds or less
- Flux Rosin flux containing small amount of chlorine (The flux with a maximum chlorine content of 0.2 Wt% is recommended.)

(a) Soldering of leads should be made at the point 1.5 to 2.0 mm from the root of the lead

(b) Please be sure that the temperature of the package would not be heated over 100°C

(4) Cautions

- Fluxes

Avoid removing the residual flux with freon-based and chlorine-based cleaning solvent.

2. Cautions regarding noise

Be aware that when voltage is applied suddenly between the photocoupler's input and output at startup, the output transistor may enter the on state, even if the voltage is within the absolute maximum ratings.

USAGE CAUTIONS

1. This product is weak for static electricity by designed with high-speed integrated circuit so protect against static electricity when handling.
2. Board designing
 - (1) By-pass capacitor of more than 0.1 μF is used between V_{CC} and GND near device. Also, ensure that the distance between the leads of the photocoupler and capacitor is no more than 10 mm.
 - (2) In order to avoid malfunctions and characteristics degradation, IGBT collector or emitter traces should not be closed to the LED input.
 - (3) Pins 1, 4 (which is an NC^{*1} pin) can either be connected directly to the GND pin on the LED side or left open.

Unconnected pins should not be used as a bypass for signals or for any other similar purpose because this may degrade the internal noise environment of the device.

***1** NC: Non-Connection (No Connection)

3. Make sure the rise/fall time of the forward current is 0.5 μs or less.
4. In order to avoid malfunctions, make sure the rise/fall slope of the supply voltage is 3 V/ μs or less.
5. Avoid storage at a high temperature and high humidity.

<R> SPECIFICATION OF VDE MARKS LICENSE DOCUMENT

Parameter	Symbol	Spec.	Unit
Climatic test class (IEC 60068-1/DIN EN 60068-1)		55/100/21	
Dielectric strength maximum operating isolation voltage Test voltage (partial discharge test, procedure a for type test and random test) $U_{pr} = 1.5 \times U_{ORM}$, $P_d < 5 \text{ pC}$	U_{ORM} U_{pr}	1 130 1 695	V_{peak} V_{peak}
Test voltage (partial discharge test, procedure b for all devices) $U_{pr} = 1.875 \times U_{ORM}$, $P_d < 5 \text{ pC}$	U_{pr}	2 119	V_{peak}
Highest permissible overvoltage	U_{TR}	8 000	V_{peak}
Degree of pollution (DIN EN 60664-1 VDE0110 Part 1)		2	
Comparative tracking index (IEC 60112/DIN EN 60112 (VDE 0303 Part 11))	CTI	175	
Material group (DIN EN 60664-1 VDE0110 Part 1)		III a	
Storage temperature range	T_{stg}	−55 to +125	°C
Operating temperature range	T_A	−40 to +100	°C
Isolation resistance, minimum value $V_{IO} = 500 \text{ V dc}$ at $T_A = 25^\circ\text{C}$ $V_{IO} = 500 \text{ V dc}$ at $T_A \text{ MAX.}$ at least 100°C	$R_{is \text{ MIN.}}$ $R_{is \text{ MIN.}}$	10^{12} 10^{11}	Ω Ω
Safety maximum ratings (maximum permissible in case of fault, see thermal derating curve) Package temperature Current (input current I_F , $P_{si} = 0$) Power (output or total power dissipation) Isolation resistance $V_{IO} = 500 \text{ V dc}$ at $T_A = T_{si}$	T_{si} I_{si} P_{si} $R_{is \text{ MIN.}}$	175 400 700 10^9	°C mA mW Ω

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Caution

GaAs Products

This product uses gallium arsenide (GaAs).

GaAs vapor and powder are hazardous to human health if inhaled or ingested, so please observe the following points.

- Follow related laws and ordinances when disposing of the product. If there are no applicable laws and/or ordinances, dispose of the product as recommended below.
 1. Commission a disposal company able to (with a license to) collect, transport and dispose of materials that contain arsenic and other such industrial waste materials.
 2. Exclude the product from general industrial waste and household garbage, and ensure that the product is controlled (as industrial waste subject to special control) up until final disposal.
- Do not burn, destroy, cut, crush, or chemically dissolve the product.
- Do not lick the product or in any way allow it to enter the mouth.